

**FEATURES**

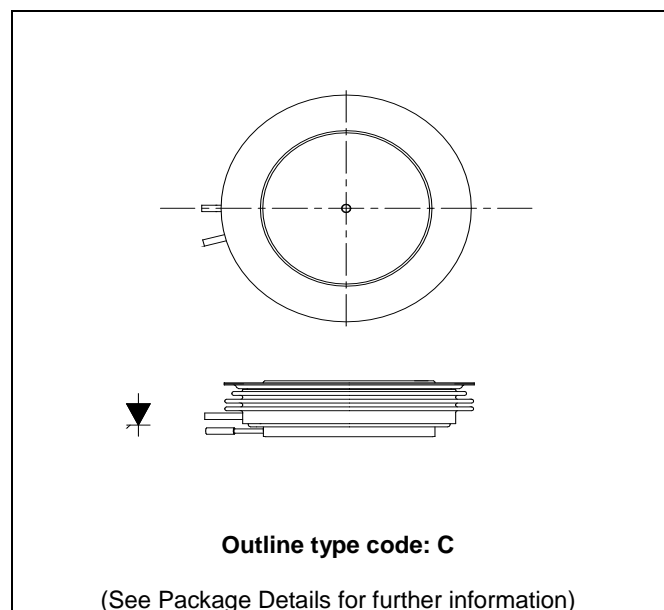
- Double Side Cooling
- High Reliability In Service
- High Voltage Capability
- Fault Protection Without Fuses
- High Surge Current Capability
- Turn-off Capability Allows Reduction in Equipment Size and Weight. Low Noise Emission Reduces Acoustic Cladding Necessary For Environmental Requirements

**APPLICATIONS**

- Variable speed AC motor drive inverters (VSD-AC) including Traction drives
- Uninterruptable Power Supplies
- High Voltage Converters
- Choppers
- Welding
- Induction Heating
- DC/DC Converters

**KEY PARAMETERS**

$I_{TCM}$	<b>3000A</b>
$V_{DRM}$	<b>4500V</b>
$I_{T(AV)}$	<b>950A</b>
$dV_D/dt^*$	<b>1000V/μs</b>
$di_T/dt$	<b>400A/μs</b>


**Fig. 1 Package outline**
**VOLTAGE RATINGS**

Type Number	Repetitive Peak Off-state Voltage $V_{DRM}$ (V)	Repetitive Peak Reverse Voltage $V_{RRM}$ (V)	Conditions
DG808BC45	4500	16	$T_{vj} = 125^{\circ}C$ , $I_{DM} = 100mA$ , $I_{RRM} = 50mA$

**CURRENT RATINGS**

Symbol	Parameter	Conditions	Max.	Units
$I_{TCM}$	Repetitive peak controllable on-state current	$V_D = 66\%V_{DRM}$ , $T_j = 125^{\circ}C$ , $di_{GQ}/dt = 40A/\mu s$ , $C_S = 4 \mu F$	3000	A
$I_{T(AV)}$	Mean on-state current	$T_{HS} = 80^{\circ}C$ , Double side cooled. Half sine 50Hz	950	A
$I_{T(RMS)}$	RMS on-state current	$T_{HS} = 80^{\circ}C$ , Double side cooled. Half sine 50Hz	1490	A

**SURGE RATINGS**

Symbol	Parameter	Test Conditions	Max.	Units
$I_{TSM}$	Surge (non repetitive) on-state current	10ms half sine. $T_j = 125^\circ\text{C}$	16.0	kA
$I^2t$	$I^2t$ for fusing	10ms half sine. $T_j = 125^\circ\text{C}$	1.28	$\text{MA}^2\text{s}$
$di_T/dt$	Critical rate of rise of on-state current	$V_D = 3000\text{V}$ , $I_T = 3000\text{A}$ , $T_j = 125^\circ\text{C}$ , $I_{FG} > 40\text{A}$ , Rise time $> 1.0 \mu\text{s}$	400	$\text{A}/\mu\text{s}$
$dV_D/dt$	Rate of rise of off-state voltage	To 66% $V_{DRM}$ ; $R_{GK} \leq 1.5\Omega$ , $T_j = 125^\circ\text{C}$	100	$\text{V}/\mu\text{s}$
		To 66% $V_{DRM}$ ; $V_{RG} \leq -2\text{V}$ , $T_j = 125^\circ\text{C}$	1000	$\text{V}/\mu\text{s}$
$L_s$	Peak stray inductance in snubber circuit	$I_T = 3000\text{A}$ , $V_D = V_{DRM}$ , $T_j = 125^\circ\text{C}$ , $dI_{GQ} = 40\text{A}/\mu\text{s}$ , $C_s = 4.0\mu\text{F}$	200	nH

**GATE RATINGS**

Symbol	Parameter	Test Conditions	Min.	Max.	Units
$V_{RGM}$	Peak reverse gate voltage	This value may exceeded during turn-off	-	16	V
$I_{FGM}$	Peak forward gate current		-	100	A
$P_{FG(AV)}$	Average forward gate power		-	20	W
$P_{RGM}$	Peak reverse gate power		-	24	kW
$dI_{GQ}/dt$	Rate of rise of reverse gate current		30	60	$\text{A}/\mu\text{s}$
$t_{ON(\text{min})}$	Minimum permissible on time		50	-	$\mu\text{s}$
$t_{OFF(\text{min})}$	Minimum permissible off time		100	-	$\mu\text{s}$

**THERMAL AND MECHANICAL RATINGS**

Symbol	Parameter	Test Conditions	Min.	Max.	Units	
$R_{th(j-hs)}$	Thermal resistance – junction to heatsink surface	Double side cooled	DC	-	0.014	$^\circ\text{C}/\text{W}$
		Single side cooled	Anode DC	-	0.0233	$^\circ\text{C}/\text{W}$
			Cathode DC	-	0.035	$^\circ\text{C}/\text{W}$
$R_{th(c-hs)}$	Contact thermal resistance	Clamping force 36.0kN With mounting compound	Per contact	-	0.0036	$^\circ\text{C}/\text{W}$
$T_{vj}$	Virtual junction temperature	On-state (conducting)	-40	125	$^\circ\text{C}$	
$T_{op}/T_{stg}$	Operating junction/storage temperature range		-40	125	$^\circ\text{C}$	
$F_m$	Clamping force		28.0	44.0	kN	

## CHARACTERISTICS

T<sub>j</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Max.	Units
V <sub>TM</sub>	On-state voltage	At 3000A peak, I <sub>G(ON)</sub> = 10A d.c.	-	3.75	V
I <sub>DM</sub>	Peak off-state current	V <sub>DRM</sub> = 4500V, V <sub>RG</sub> = 0V	-	100	mA
I <sub>RRM</sub>	Peak reverse current	V <sub>RRM</sub> = 16V	-	50	mA
V <sub>GT</sub>	Gate trigger voltage	V <sub>D</sub> = 24V, I <sub>T</sub> = 100A, T <sub>j</sub> = 25°C	-	1.2	V
I <sub>GT</sub>	Gate trigger current	V <sub>D</sub> = 24V, I <sub>T</sub> = 100A, T <sub>j</sub> = 25°C	-	3.5	A
I <sub>RGM</sub>	Reverse gate cathode current	V <sub>RGM</sub> = 16V, No gate/cathode resistor	-	10	mA
E <sub>ON</sub>	Turn-on Energy	V <sub>D</sub> = 3000V	-	2860	mJ
t <sub>d</sub>	Delay time	I <sub>T</sub> = 3000A, dI <sub>T</sub> /dt = 300A/μs	-	2.1	μs
t <sub>r</sub>	Rise time	I <sub>FG</sub> = 40A, rise time < 1.0μs	-	4.8	μs
E <sub>OFF</sub>	Turn-off energy	I <sub>T</sub> = 3000A, V <sub>DM</sub> = V <sub>DRM</sub> Snubber Cap C <sub>s</sub> = 4.0μC di <sub>GQ</sub> /dt = 40A/us	-	12000	mJ
t <sub>gs</sub>	Storage time		-	25	μs
t <sub>gf</sub>	Fall time		2	μs	
t <sub>gq</sub>	Gate controlled turn-off time		-	27	μs
Q <sub>GQ</sub>	Turn-off gate charge		12000	μC	
Q <sub>GQT</sub>	Total turn-off gate charge		24000	μC	
I <sub>GQM</sub>	Peak reverse gate current		-	800	A

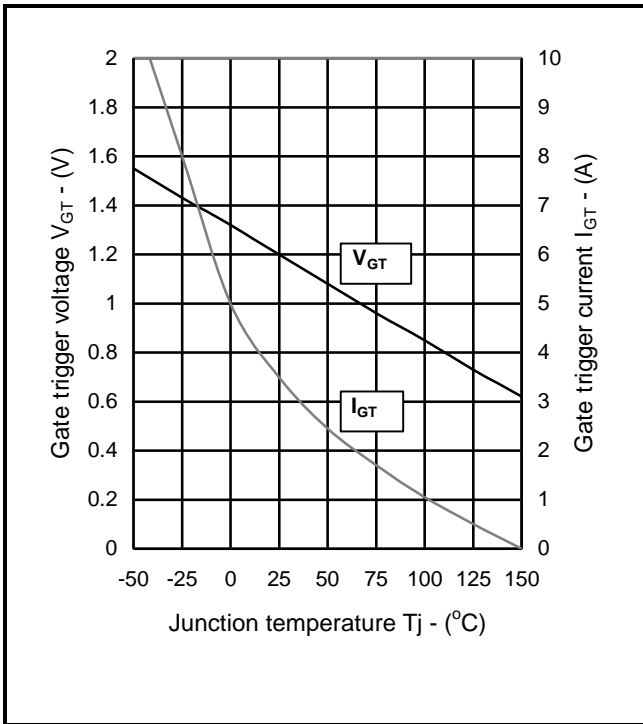


Fig.2 Maximum gate trigger voltage/current vs junction temperature

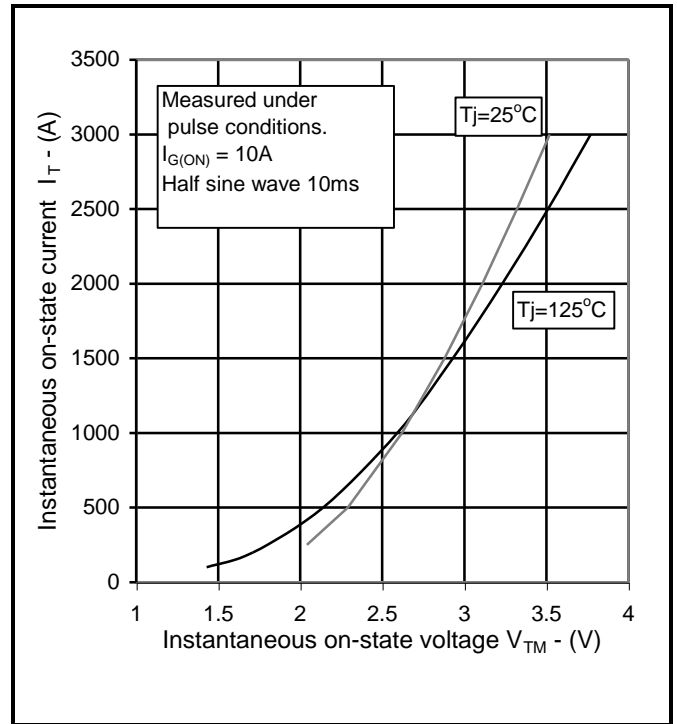


Fig.3 On-state characteristics

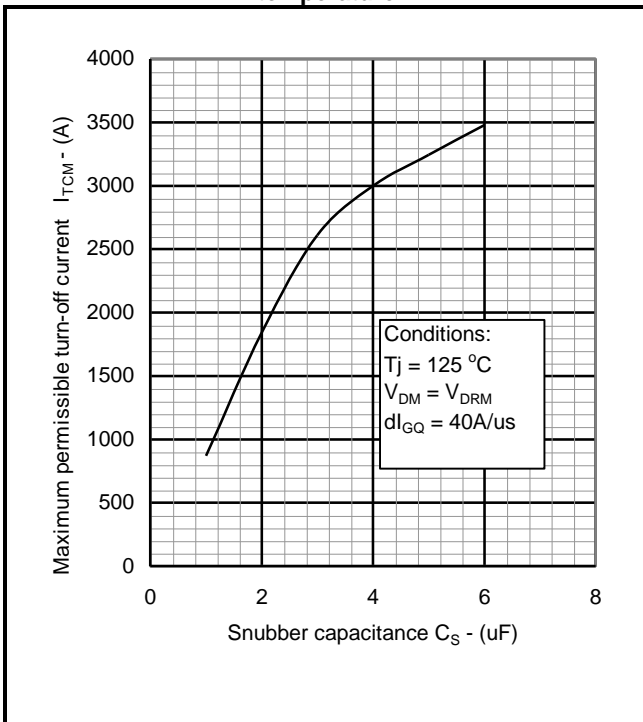


Fig.4 Maximum dependence of  $I_{TCM}$  on  $C_s$

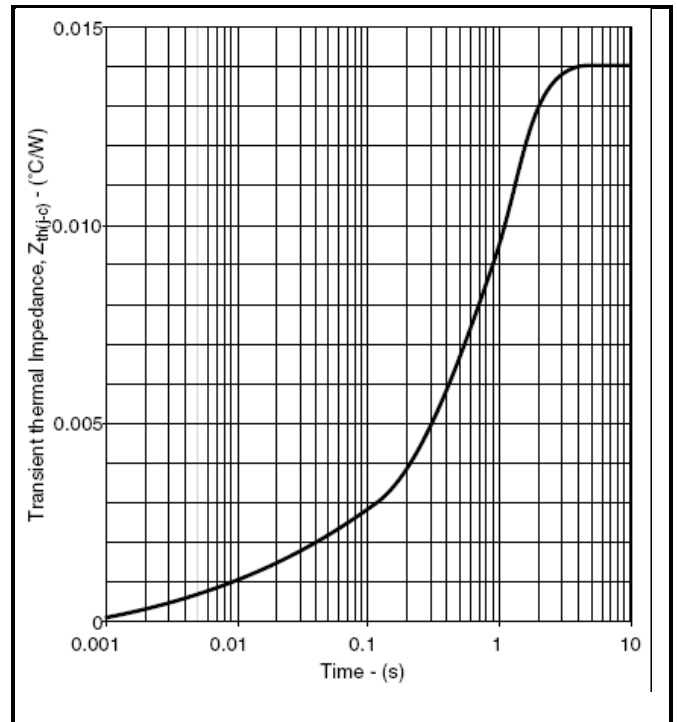


Fig.5 Maximum (limit) transient thermal impedance-double side cooled

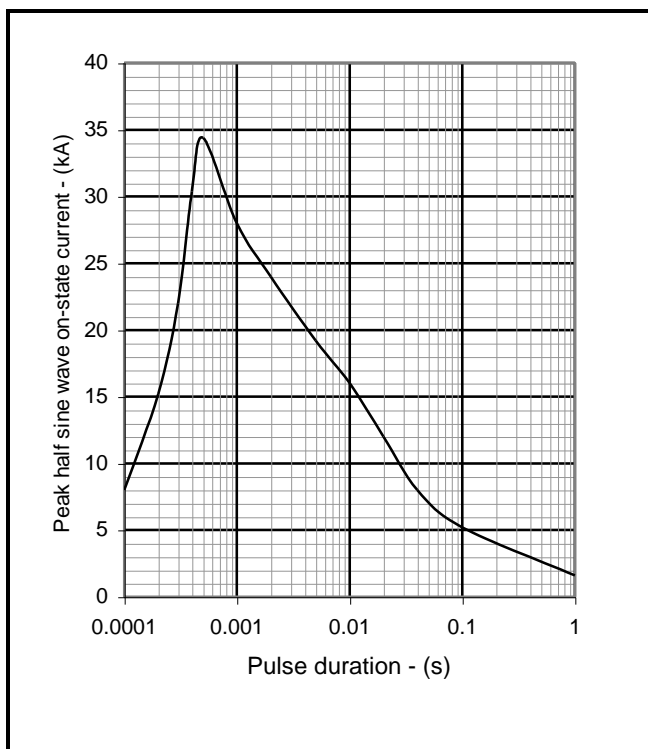


Fig.6 Surge (non-repetitive) on-state current vs time

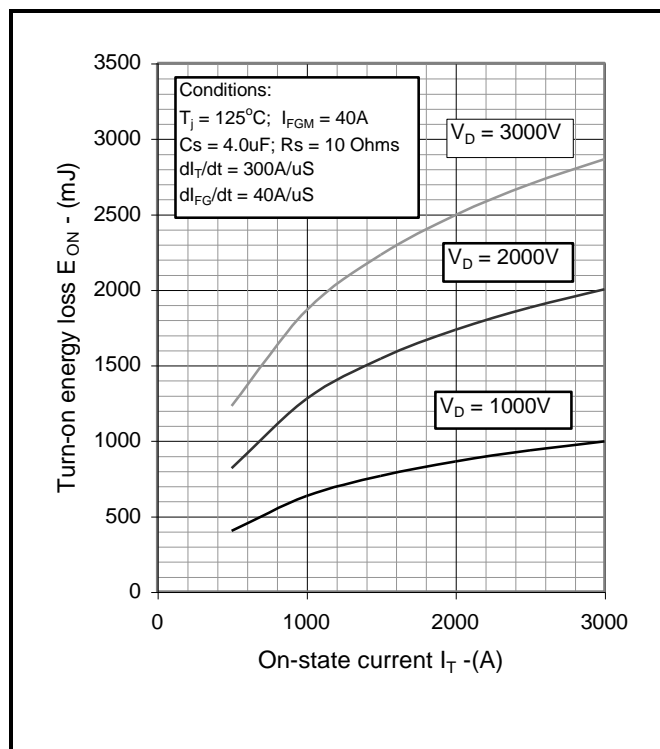


Fig.7 Turn-on energy vs on-state current

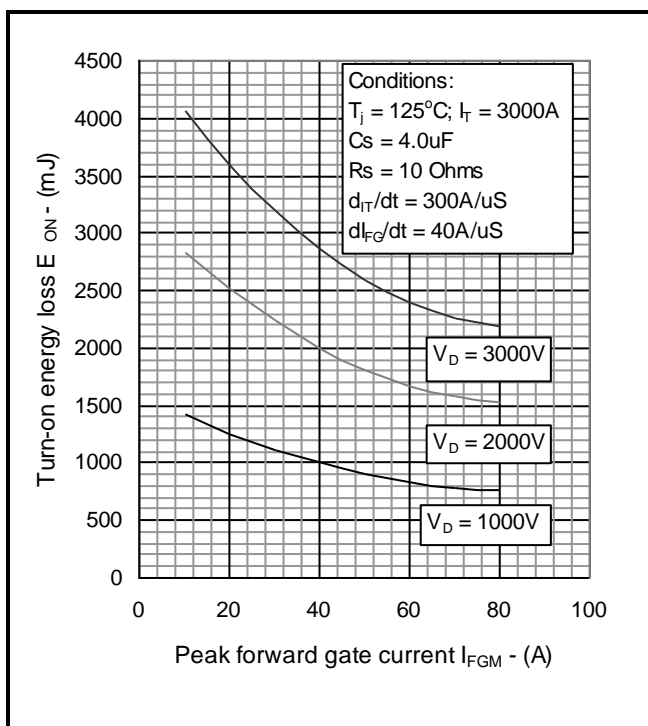


Fig.8 Turn-on energy vs forward gate current

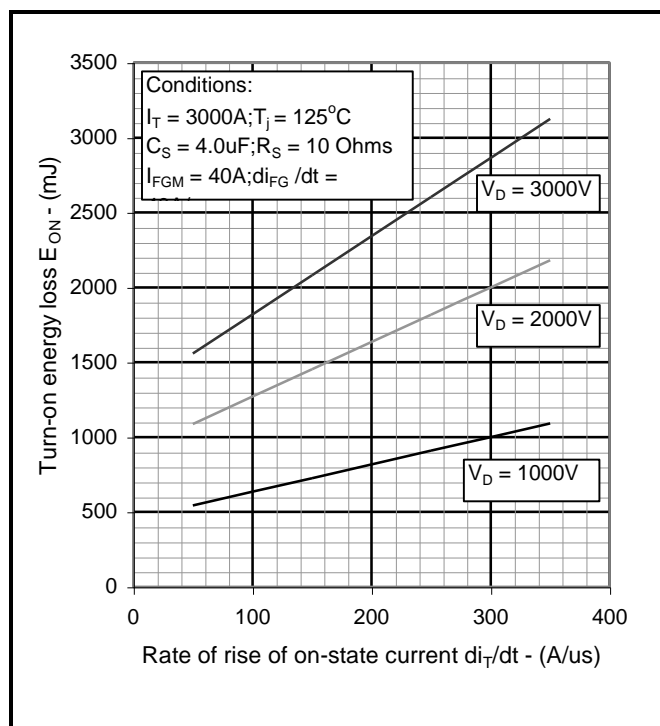


Fig.9 Turn-on energy vs rate of rise of on-state current

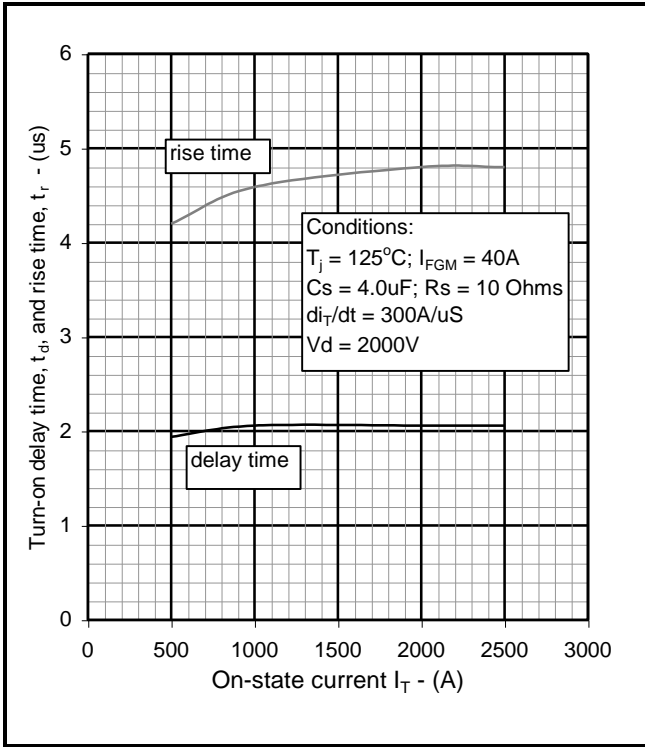


Fig.10 Delay and rise time vs on-state current

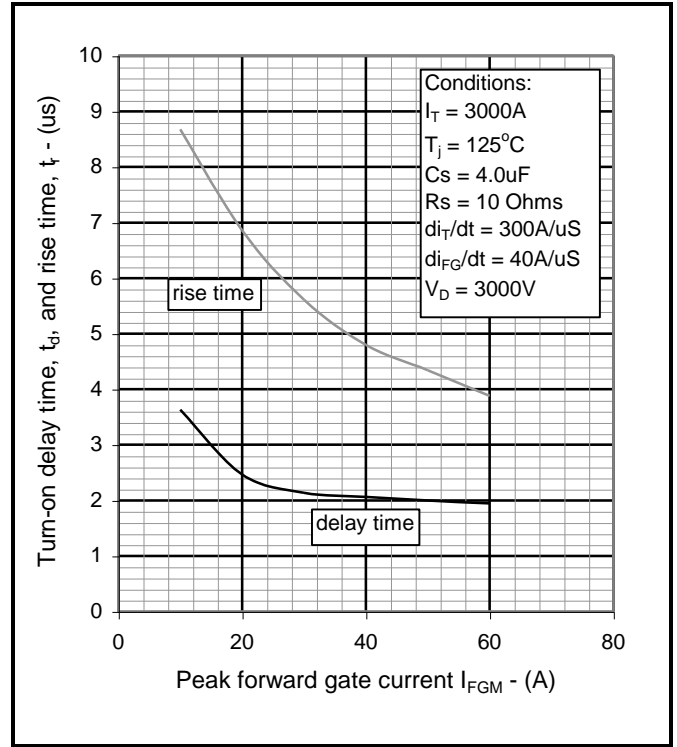


Fig.11 Delay and rise time vs peak forward gate current

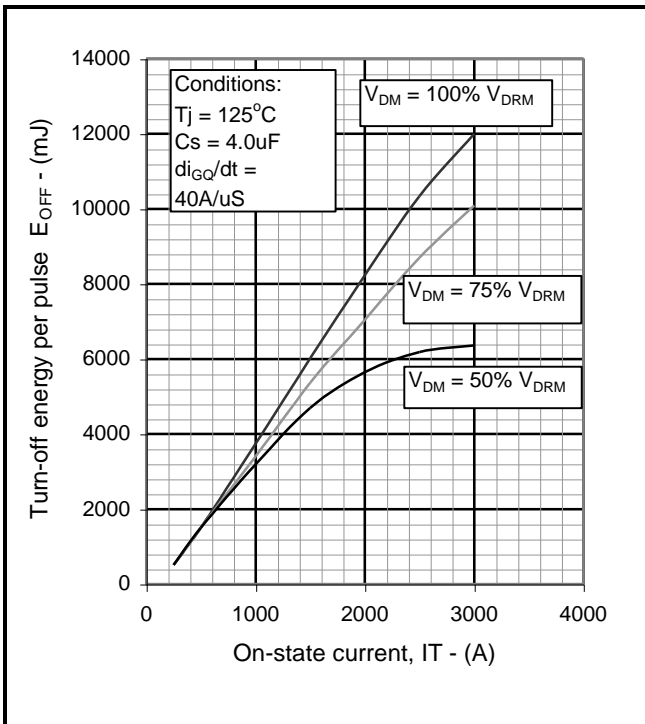


Fig.12 Turn-off energy vs on-state current

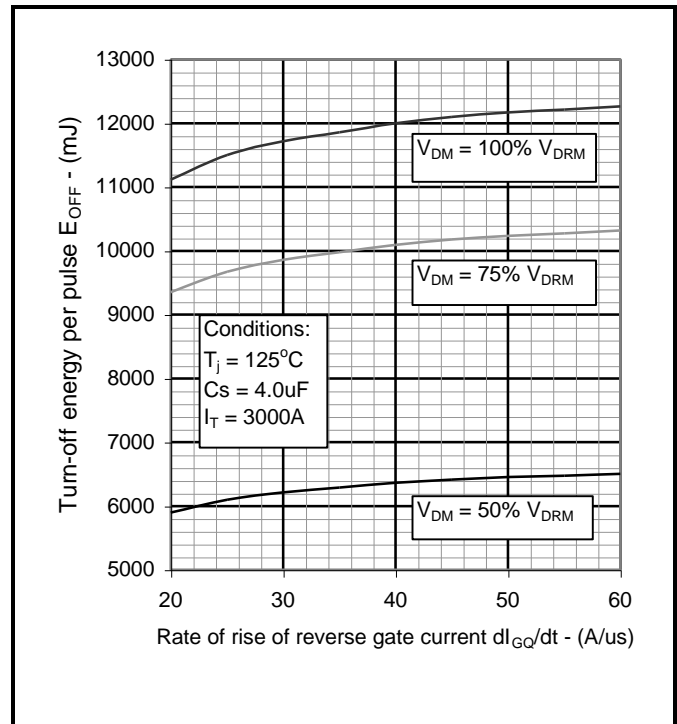


Fig.13 Turn-off energy loss vs rate of rise of reverse gate current

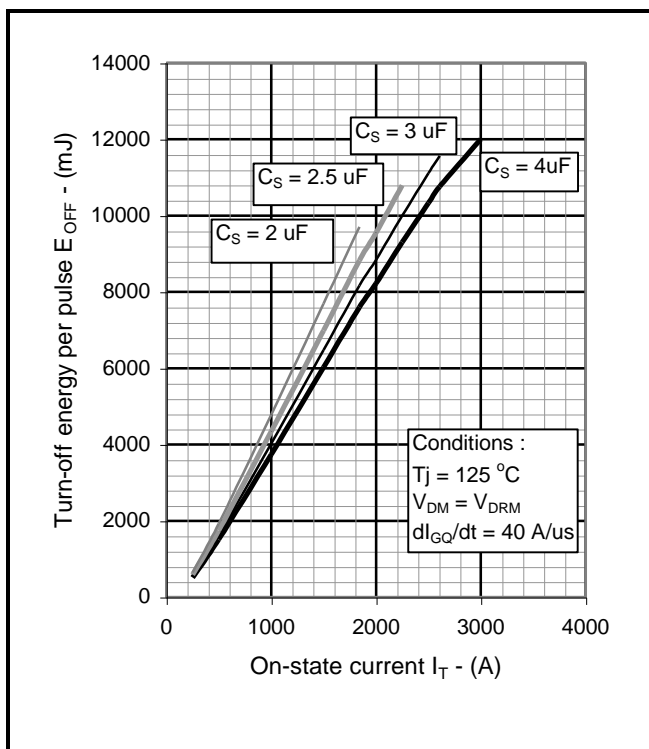


Fig.14 Turn-off energy vs on-state current

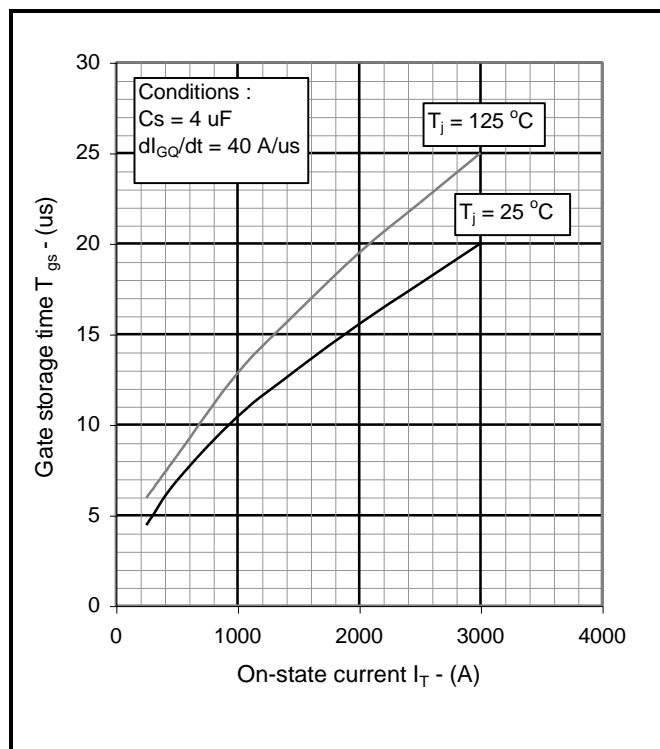


Fig.15 Gate storage time vs on-state current

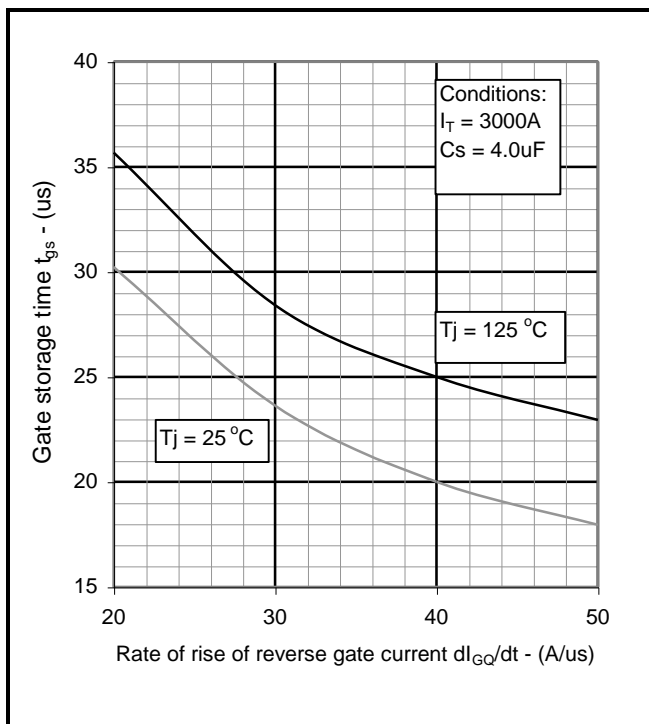


Fig.16 Gate storage time vs rate of rise of reverse gate current

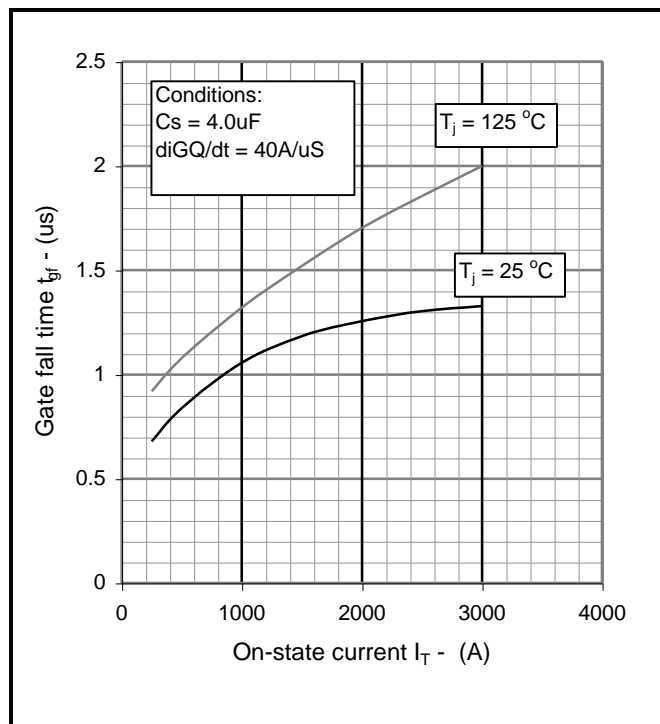


Fig.17 Gate fall time vs on-state current

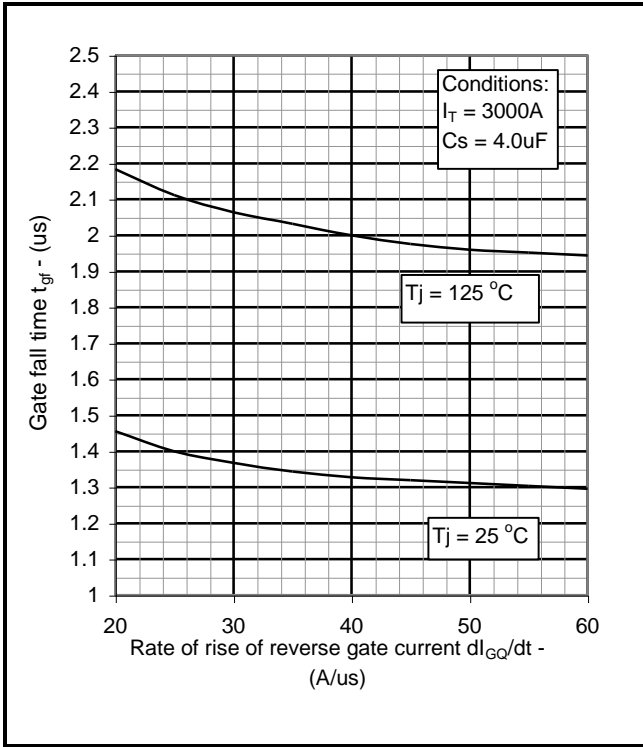


Fig.18 Gate fall time vs rate of rise of reverse gate current

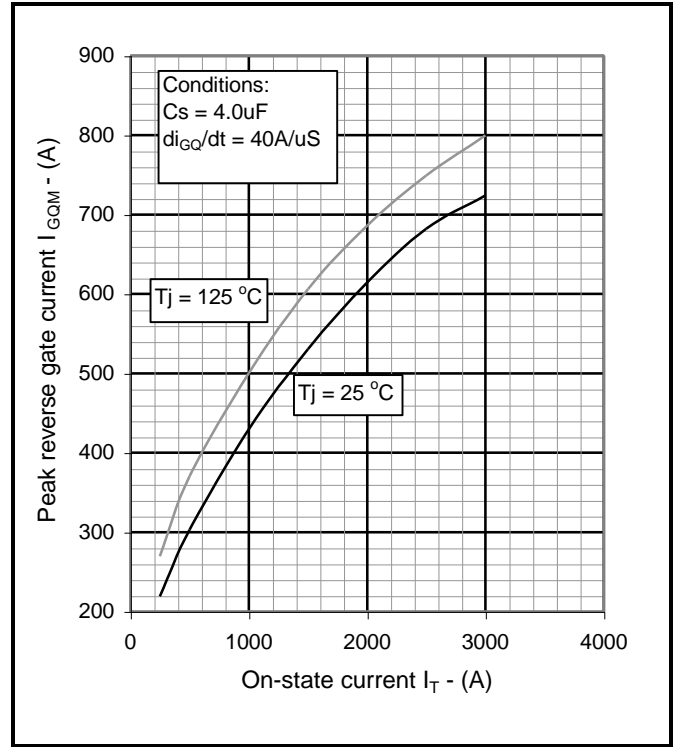


Fig.19 Peak reverse gate current vs on-state current

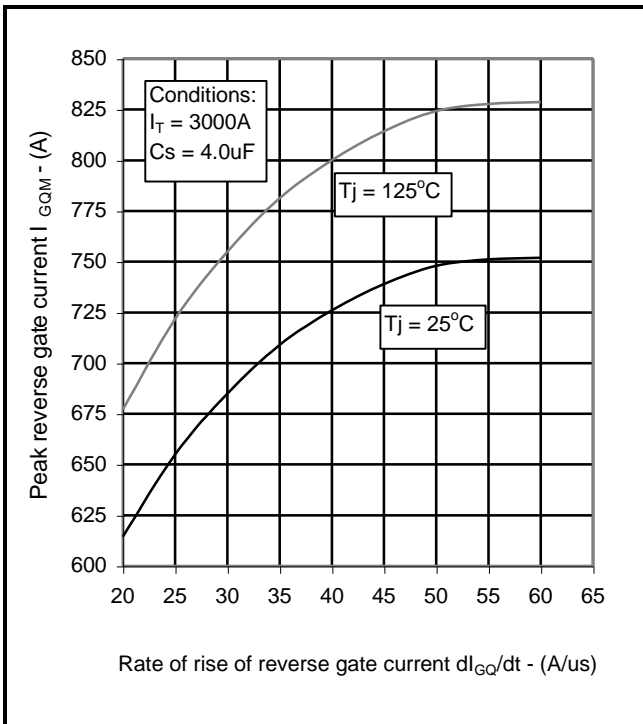


Fig.20 Reverse gate current vs rate of rise of reverse gate current

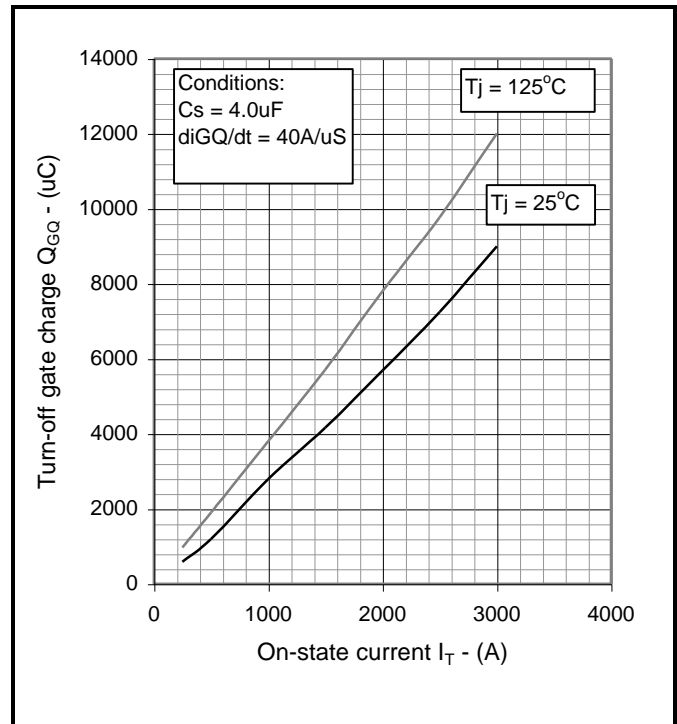


Fig.21 Turn-off gate charge vs on-state current



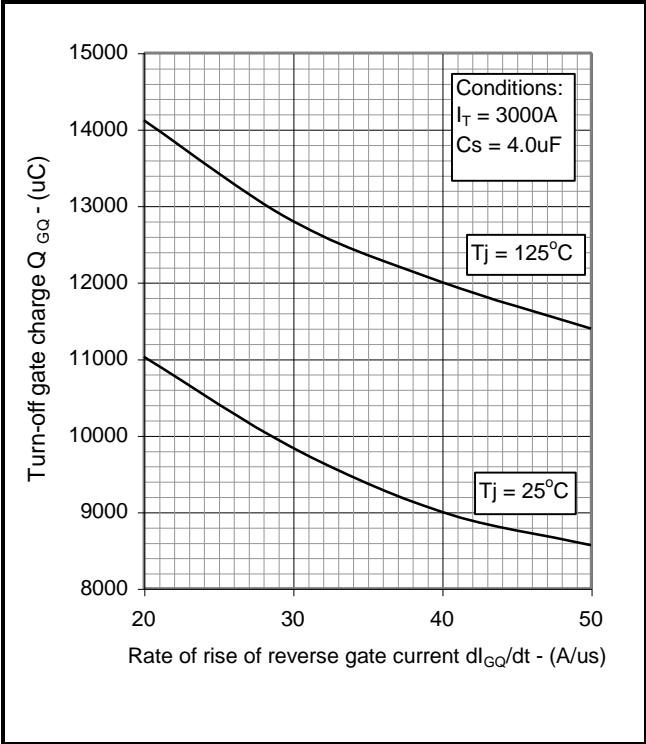


Fig.22 Turn-off charge vs rate of rise of reverse gate current

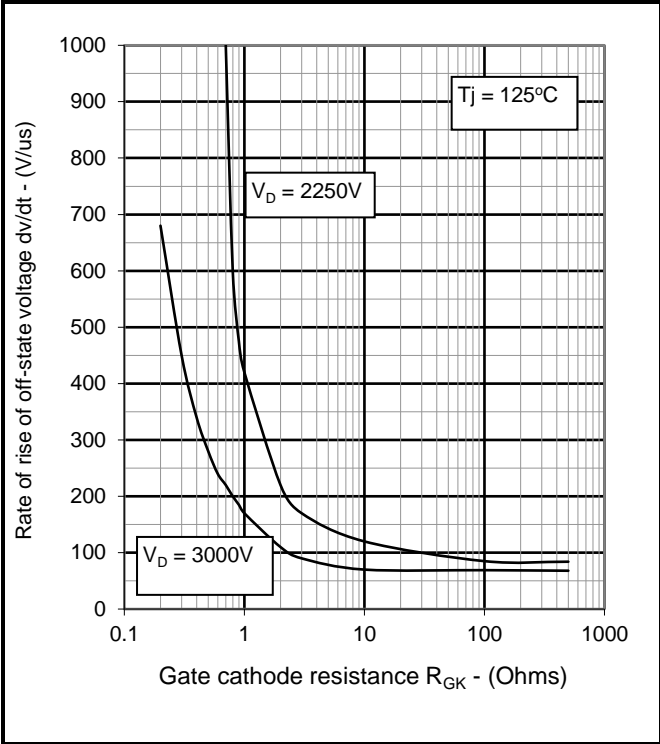
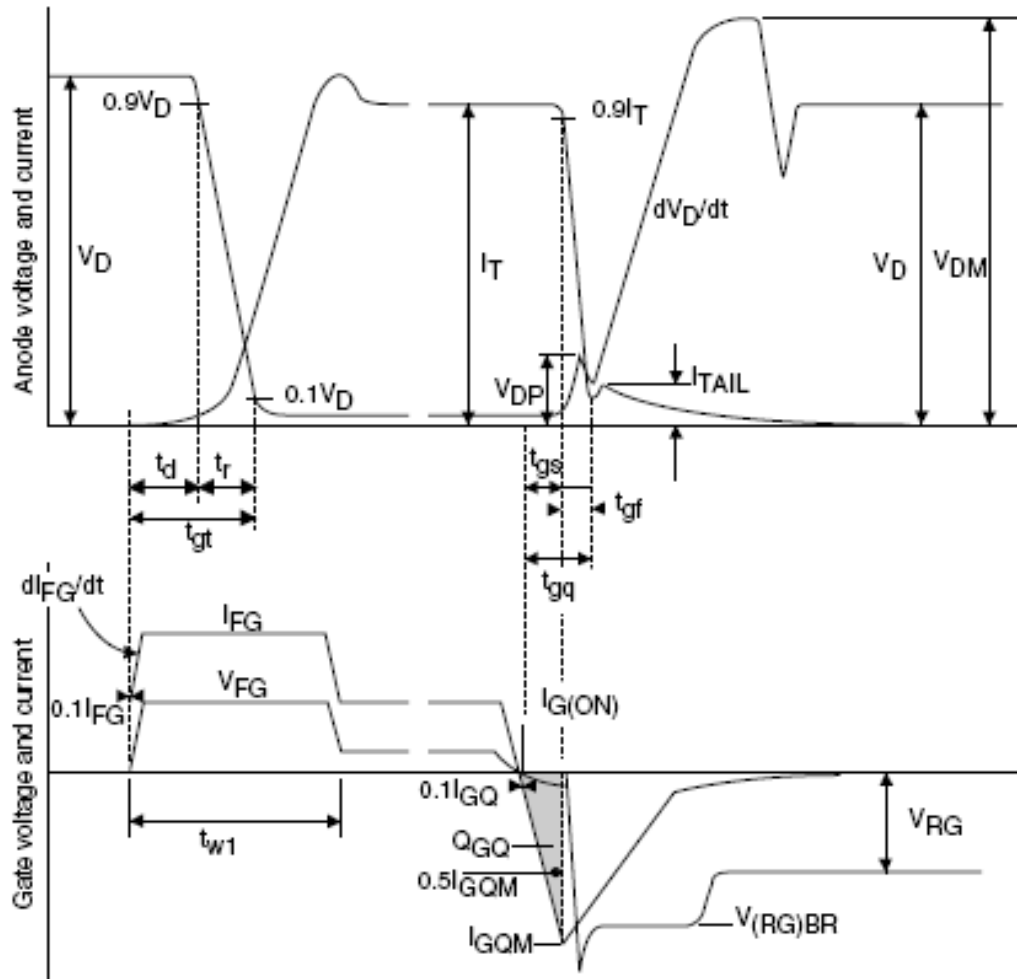


Fig.23 Rate of rise of off-state voltage vs gate cathode resistance



Recommended gate conditions:

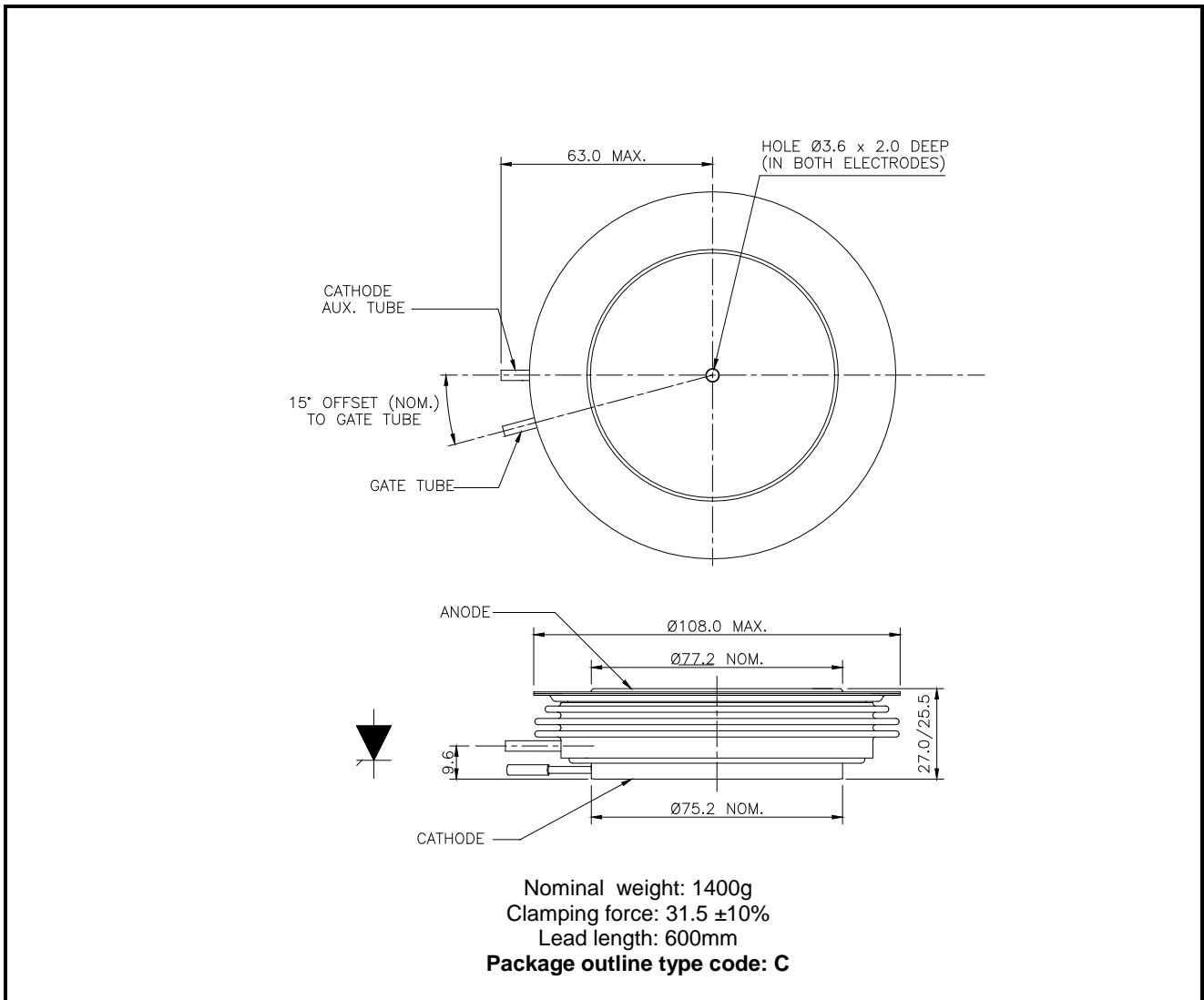
- $I_{TCM} = 1000A$
- $I_{FG} = 30A$
- $I_{G(ON)} = 4A$  d.c.
- $t_{w1(min)} = 10\mu s$
- $I_{GQM} = 420A$
- $dI_{GC}/dt = 30A/\mu s$
- $Q_{GQ} = 3000\mu C$
- $V_{RG(min)} = 2V$
- $V_{RG(max)} = 16V$

These are recommended Dynex Semiconductor conditions. Other conditions are permitted according to users gate drive specifications.

Fig.24 General switching waveforms

**PACKAGE DETAILS**

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.



**Fig.31 Package outline**

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